

### F650B-VB Datasheet

# N-Channel 200 V (D-S) MOSFET

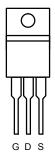
PRODUCT SUMMARY				
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A)		
200	0.058at V <sub>GS</sub> = 10 V	35		

#### **FEATURES**

- TrenchFET<sup>®</sup> Power MOSFETS
- 175 °C Junction Temperature
- New Low Thermal Resistance Package
- · Compliant to RoHS Directive 2002/95/EC

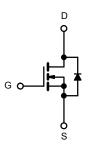


#### TO-220AB



#### **APPLICATIONS**

Industrial



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> = 25 °C, unless otherwise noted)						
Parameter	Symbol	Limit	Unit			
Drain-Source Voltage	V <sub>DS</sub>	200	V			
Gate-Source Voltage	V <sub>GS</sub>	± 20	7 v			
Continuous Drain Current (T <sub>.1</sub> = 175 °C)	T <sub>C</sub> = 25 °C	L .	35			
Continuous Diain Current (1) = 173 C)	T <sub>C</sub> = 125 °C	l <sub>D</sub>	23	Α		
Pulsed Drain Current	I <sub>DM</sub>	70	1 ^			
Avalanche Current	I <sub>AR</sub>	35				
Repetitive Avalanche Energy <sup>a</sup>	L = 0.1 mH	E <sub>AR</sub>	61	mJ		
Marian and Device Discipations	T <sub>C</sub> = 25 °C	P <sub>D</sub>	300 <sup>b</sup>	W		
Maximum Power Dissipation <sup>a</sup>	T <sub>A</sub> = 25 °C <sup>c</sup>	l'D	3.75	VV		
Operating Junction and Storage Temperature Ra	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 175	°C			

THERMAL RESISTANCE RATINGS					
Parameter	Symbol	Limit	Unit		
Junction-to-Ambient (PCB Mount) <sup>c</sup>	R <sub>thJA</sub>	40	°C/W		
Junction-to-Case (Drain)	R <sub>thJC</sub>	0.5	C/VV		

#### Notes:

- a. Duty cycle  $\leq$  1 %.
- b. See SOA curve for voltage derating.
- c. When mounted on 1" square PCB (FR-4 material).



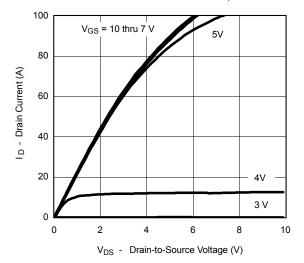
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Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit		
Static  Drain-Source Breakdown Voltage V <sub>DS</sub> V <sub>DS</sub> = 0 V, I <sub>D</sub> = 250 μA 200								
Drain-Source Breakdown Voltage	V <sub>DS</sub>	50 5 1	200			V		
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	2		4			
Gate-Body Leakage	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ± 30 V			± 250	nA		
		V <sub>DS</sub> = 200 V, V <sub>GS</sub> = 0 V			1	μΑ		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 200 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 125 ^{\circ}\text{C}$			50			
		V <sub>DS</sub> = 200 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 175 °C			250			
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	70			Α		
		$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$		0.058		Ω		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DQ</sub> ,	$V_{GS}$ = 10 V, $I_{D}$ = 20 A, $T_{J}$ = 125 °C		0.130				
Dialii-Source Oil-State Resistance	R <sub>DS(on)</sub>	$V_{GS}$ = 10 V, $I_{D}$ = 20 A, $T_{J}$ = 175 °C		0.170				
		V <sub>GS</sub> = 6 V, I <sub>D</sub> = 15 A		0.070				
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 20 A		70		S		
Dynamic <sup>b</sup>	•			•				
Input Capacitance	C <sub>iss</sub>			2690		pF		
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1 MHz		200				
Reverse Transfer Capacitance	C <sub>rss</sub>			110				
Total Gate Charge <sup>c</sup>	$Q_g$			95	140			
Gate-Source Charge <sup>c</sup>	Q <sub>gs</sub>	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 45 A		28		nC		
Gate-Drain Charge <sup>c</sup>	Q <sub>gd</sub>			34				
Gate Resistance	R <sub>g</sub>	f = 1 MHz		1.6		Ω		
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>			22	35			
Rise Time <sup>c</sup>	t <sub>r</sub>	$V_{DD} = 100 \text{ V}, R_1 = 2.78 \Omega$		220	330			
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>	$I_D \cong 45 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 2.5 \Omega$		40	60	ns		
Fall Time <sup>c</sup>	t <sub>f</sub>			145	220	1		
Source-Drain Diode Ratings and Cha	aracteristics (	T <sub>C</sub> = 25 °C) <sup>b</sup>						
Continuous Current	I <sub>S</sub>				45			
Pulsed Current	I <sub>SM</sub>				70	Α		
Forward Voltage <sup>a</sup>	V <sub>SD</sub>	I <sub>F</sub> = 45 A, V <sub>GS</sub> = 0 V		1	1.5	V		
Reverse Recovery Time	t <sub>rr</sub>	. 55		150	225	ns		
Peak Reverse Recovery Current	I <sub>RM(REC)</sub>	I <sub>F</sub> = 45 A, di/dt = 100 A/μs		12	18	Α		
Reverse Recovery Charge	Q <sub>rr</sub>			0.9	2	uС		

- a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

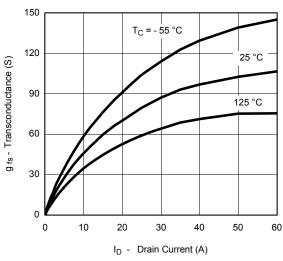
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



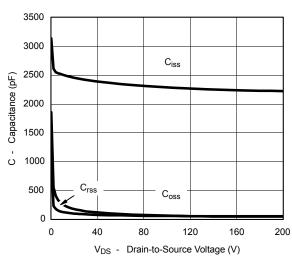
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



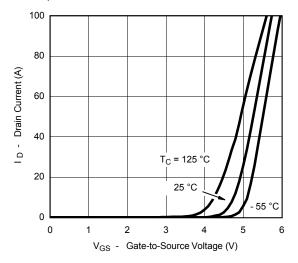
#### **Output Characteristics**



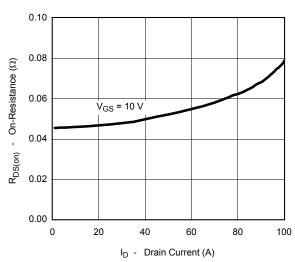
#### Transconductance



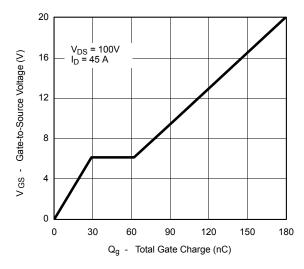
#### Capacitance



#### **Transfer Characteristics**



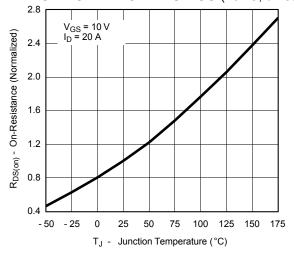
#### On-Resistance vs. Drain Current



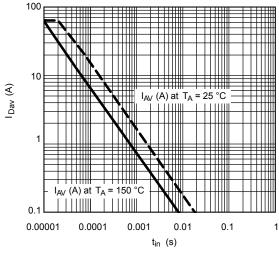
**Gate Charge** 



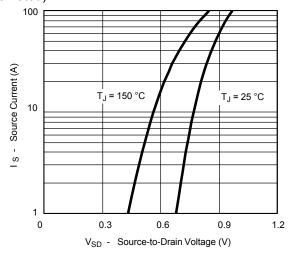
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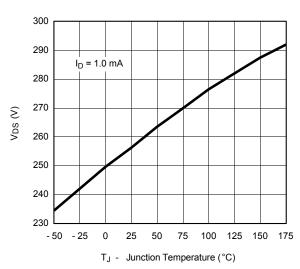
#### On-Resistance vs. Junction Temperature



**Avalanche Current vs. Time** 



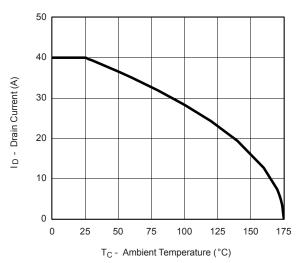
#### Source-Drain Diode Forward Voltage

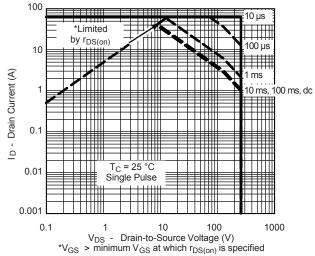


Drain Source Breakdown vs. Junction Temperature



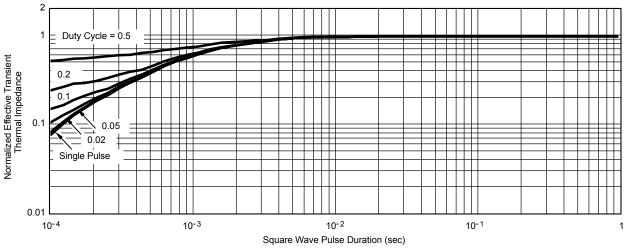
#### THERMAL RATINGS





Maximum Avalanche and Drain Current vs. Case Temperature

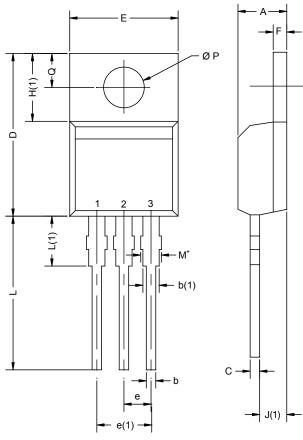
Safe Operating Area, Case Temperature



Normalized Thermal Transient Impedance, Junction-to-Case



# **TO-220AB**



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		D2

	MILLIMETERS		INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
D2	12.19	12.70	0.480	0.500	
Е	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØΡ	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: T14-0413-Rev. P, 16-Jun-14 DWG: 5471					

#### Note

 $^{\star}$  M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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